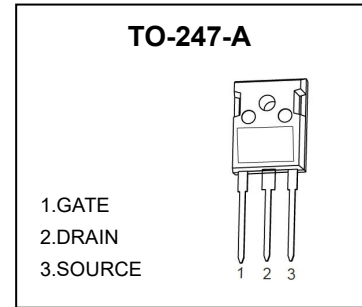


**TO-247-A Plastic-Encapsulate MOSFET**

**CJWT022SN25MK** N-Channel Power MOSFET

**Key Performance Parameters**

<b>V<sub>BR(DSS)</sub></b>	<b>R<sub>DS(on)TYP</sub></b>	<b>I<sub>D</sub></b>
<b>250V</b>	<b>17mΩ@10V</b>	<b>100A</b>



**DESCRIPTION**

The N-Channel enhancement mode power field effect transistors is using SGT technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

**FEATURES**

- 100% Avalanche tested
- Low drain-source on-resistance
- Low gate charge
- High current capability

**APPLICATIONS**

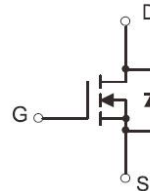
- DC/DC
- Switching application

**MARKING**



XXXXXX = 022SN25MK  
 Solid dot = Green molding compound device.  
 YYYY = Code.

**EQUIVALENT CIRCUIT**



**ABSOLUTE MAXIMUM RATINGS ( T<sub>J</sub>=25°C unless otherwise specified )**

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DS</sub>	250	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current	I <sub>D</sub>	T <sub>C</sub> =25°C	100
		T <sub>C</sub> =100°C	63
Pulsed Drain Current	I <sub>DM</sub> <sup>①②</sup>	400	A
Continuous Drain Current	I <sub>D</sub>	T <sub>A</sub> =25°C	7.1
		T <sub>A</sub> =75°C	5.5
Avalanche Current	I <sub>AS</sub> <sup>③</sup>	24	A
Single Pulsed Avalanche Energy	E <sub>AS</sub> <sup>③</sup>	144	mJ
Power Dissipation	P <sub>D</sub> <sup>①</sup>	625	W
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55~+150	°C

**Thermal Characteristics**

Parameter	Symbol	Value		Unit
		Typ	Max	
Thermal Resistance from Junction to Case	R <sub>θJC</sub>	0.14	0.2	°C/W
Thermal Resistance from Junction to Ambient	R <sub>θJA</sub> <sup>⑥</sup>	30	45	°C/W

# Typical Characteristics

## ELECTRICAL CHARACTERISTICS (T<sub>J</sub>=25°C unless otherwise specified)

### Static Characteristics

Parameter	Symbol	Test Condition	Value			Unit	
			Min	Typ	Max		
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	250	-	-	V	
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> =250V, V <sub>GS</sub> =0V	T <sub>J</sub> =25°C	-	-	1.0	μA
			T <sub>J</sub> =125°C	-	-	100	
Gate-body leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	-	-	±100	nA	
Gate-threshold voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	2.0	3.1	4.0	V	
Static drain-source on-state resistance	R <sub>Ds(on)</sub> <sup>④</sup>	V <sub>GS</sub> =10V, I <sub>D</sub> =20A	T <sub>J</sub> =25°C	-	17	22	mΩ
			T <sub>J</sub> =125°C	-	37	48	
Forward transconductance	g <sub>FS</sub>	V <sub>DS</sub> =5V, I <sub>D</sub> =20A	-	80	-	S	

### Dynamic Characteristics<sup>⑤</sup>

Input capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =125V, f=1MHz	-	5430	-	pF
Output capacitance	C <sub>oss</sub>		-	300	-	
Reverse transfer capacitance	C <sub>rss</sub>		-	6	-	
Gate resistance	R <sub>g</sub>	f=1MHz	-	3.1	-	Ω
Total gate charge	Q <sub>g</sub>	V <sub>GS</sub> =10V, V <sub>DS</sub> =125V, I <sub>D</sub> =20A	-	66.5	-	nC
Gate charge at threshold	Q <sub>G(th)</sub>		-	15.5	-	
Gate-source charge	Q <sub>gs</sub>		-	21.6	-	
Gate-drain charge	Q <sub>gd</sub>		-	9.7	-	
Turn-on delay time	t <sub>d(on)</sub>	V <sub>DD</sub> =125V, V <sub>GS</sub> =10V, I <sub>D</sub> =20A, R <sub>g</sub> =10Ω	-	22	-	ns
Turn-on rise time	t <sub>r</sub>		-	63	-	
Turn-off delay time	t <sub>d(off)</sub>		-	100	-	
Turn-off fall time	t <sub>f</sub>		-	54	-	

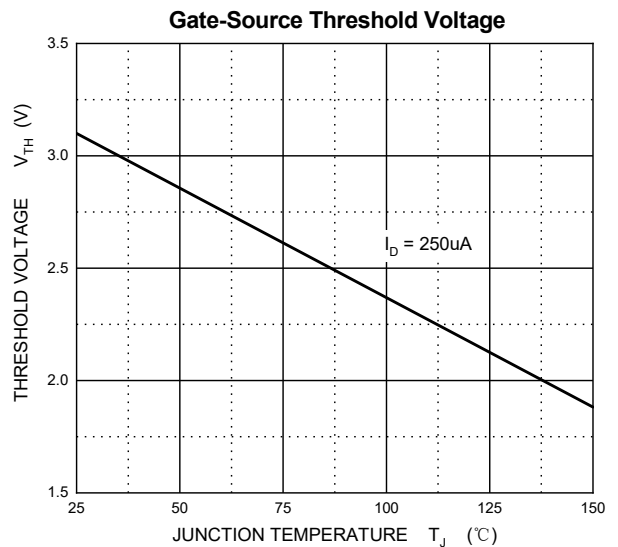
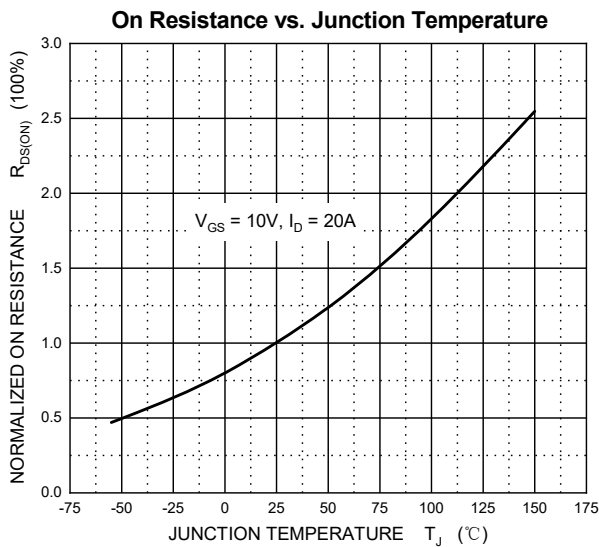
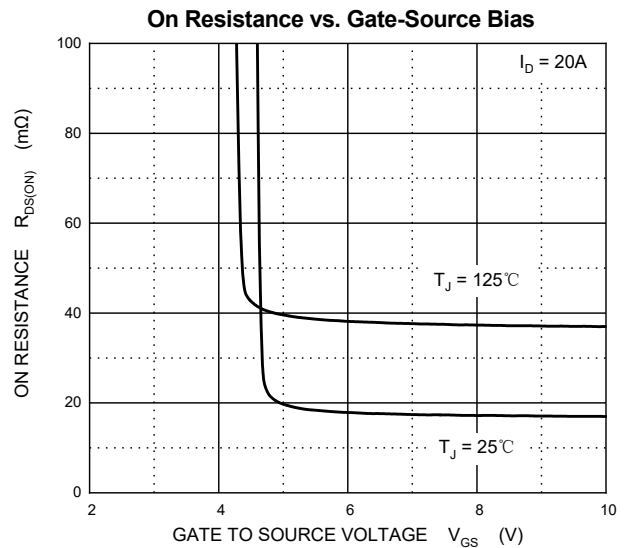
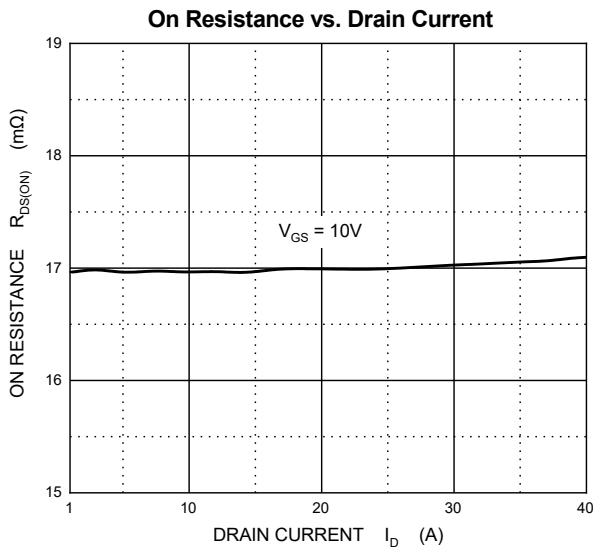
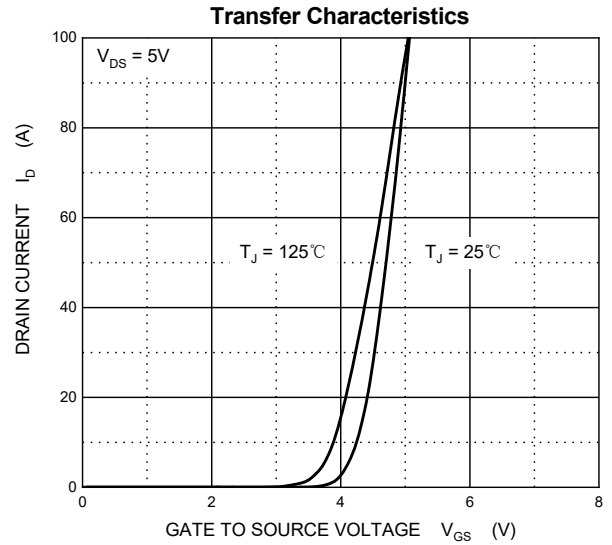
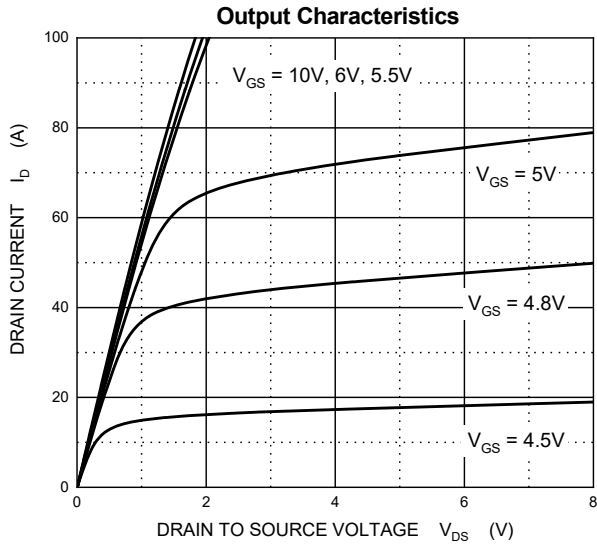
### Reverse Diode Characteristics

Drain-source diode forward voltage	V <sub>SD</sub> <sup>④</sup>	V <sub>GS</sub> =0V, I <sub>S</sub> =20A	-	-	1.2	V
Continuous drain-source diode forward current	I <sub>S</sub> <sup>①</sup>		-	-	100	A
Pulsed drain-source diode forward current	I <sub>SM</sub> <sup>①②</sup>		-	-	400	A
Reverse recovery time	t <sub>rr</sub>	V <sub>DD</sub> =125V, I <sub>S</sub> =20A,	-	172	-	ns
Reverse recovery charge	Q <sub>rr</sub>	di/dt=100A/μs	-	1286	-	nC

Notes:

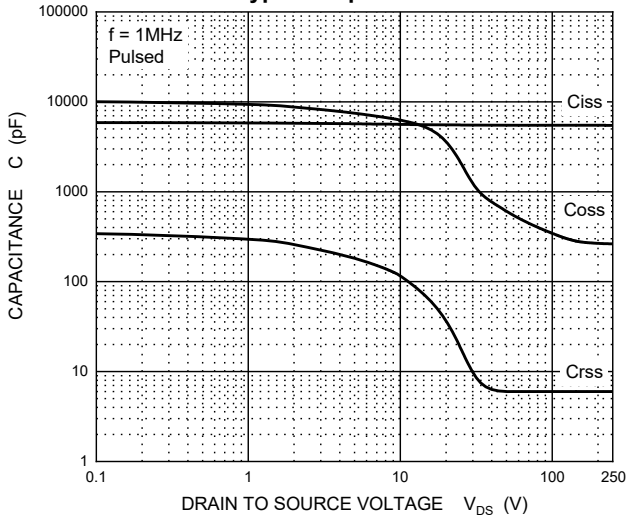
- ①. T<sub>C</sub>=25°C Limited only by maximum temperature allowed.
- ②. P<sub>w</sub>≤10μs, Duty cycle ≤1%.
- ③. EAS condition: V<sub>DD</sub>=125V, V<sub>GS</sub>=10V, L=0.5mH, R<sub>g</sub>=25Ω Starting T<sub>J</sub>=25°C.
- ④. Pulse Test : Pulse Width ≤380μs, duty cycle ≤2%.
- ⑤. Guaranteed by design, not subject to production.
- ⑥. Device mounted in a still air environment with T<sub>A</sub>=25°C.

# Typical Characteristics

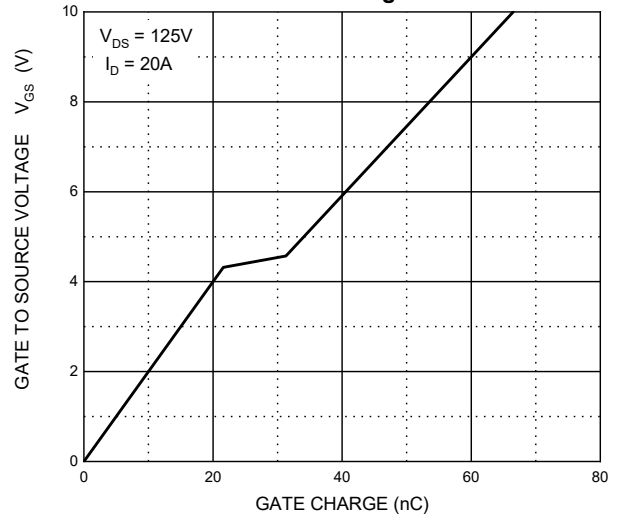


# Typical Characteristics

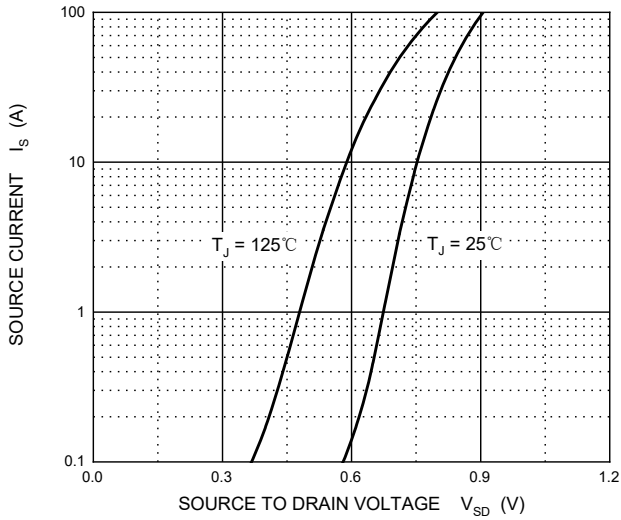
**Typical Capacitances**



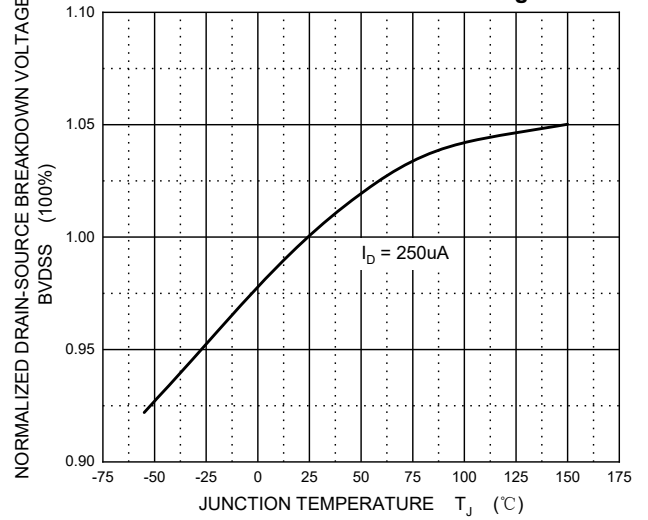
**Gate Charge**



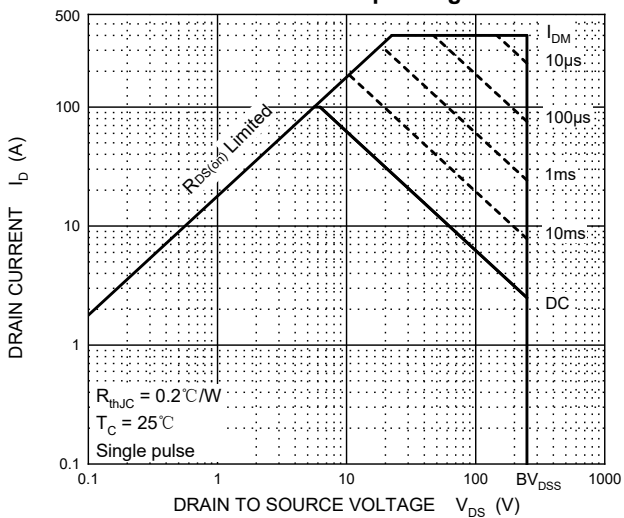
**Source-Drain Diode Forward Characteristics**



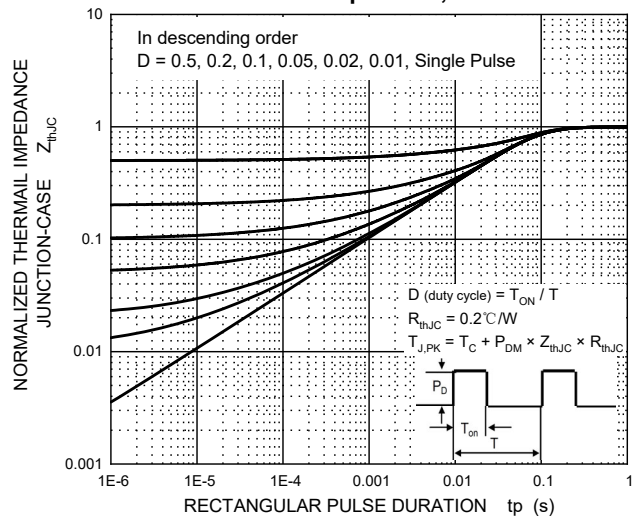
**Drain-Source Breakdown Voltage**

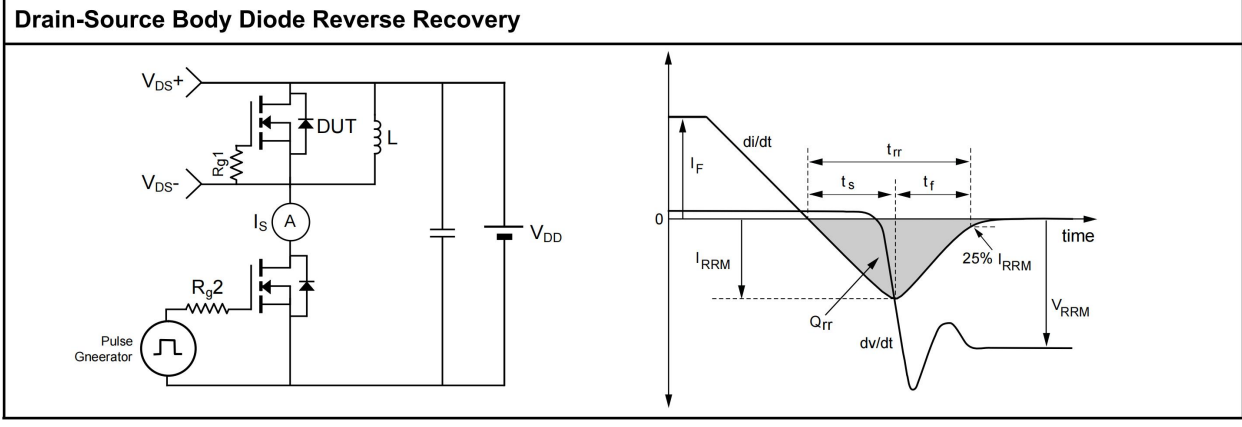
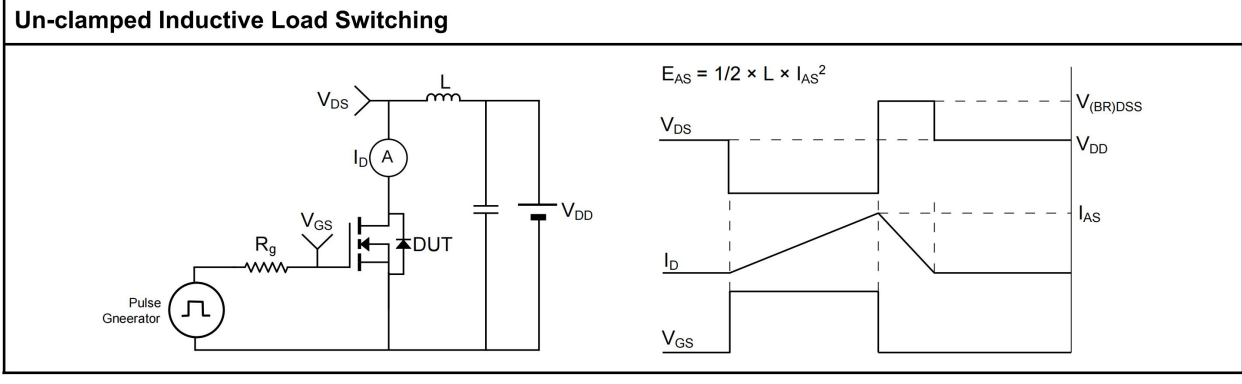
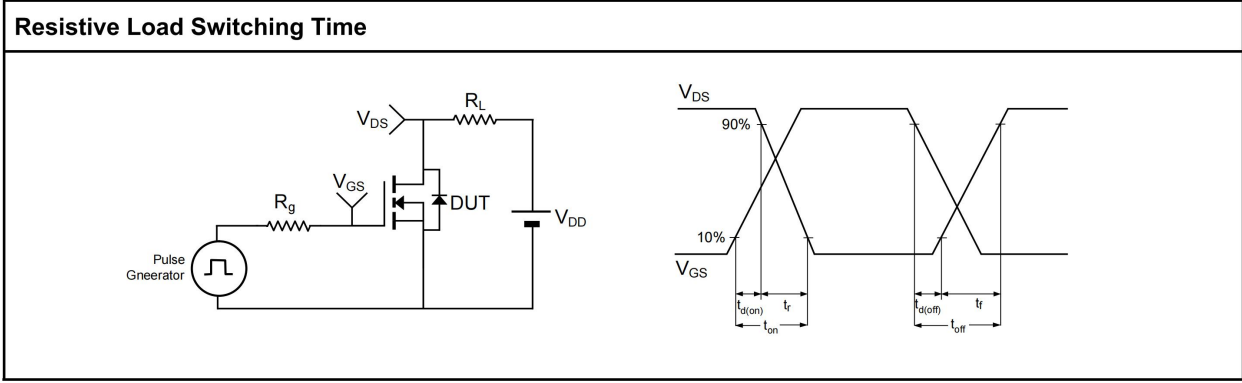
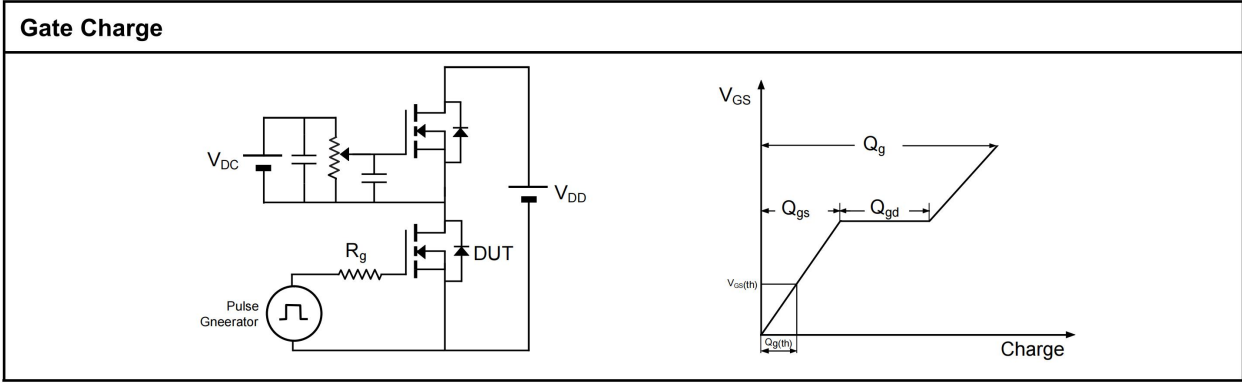


**Maximum Safe Operating Area**

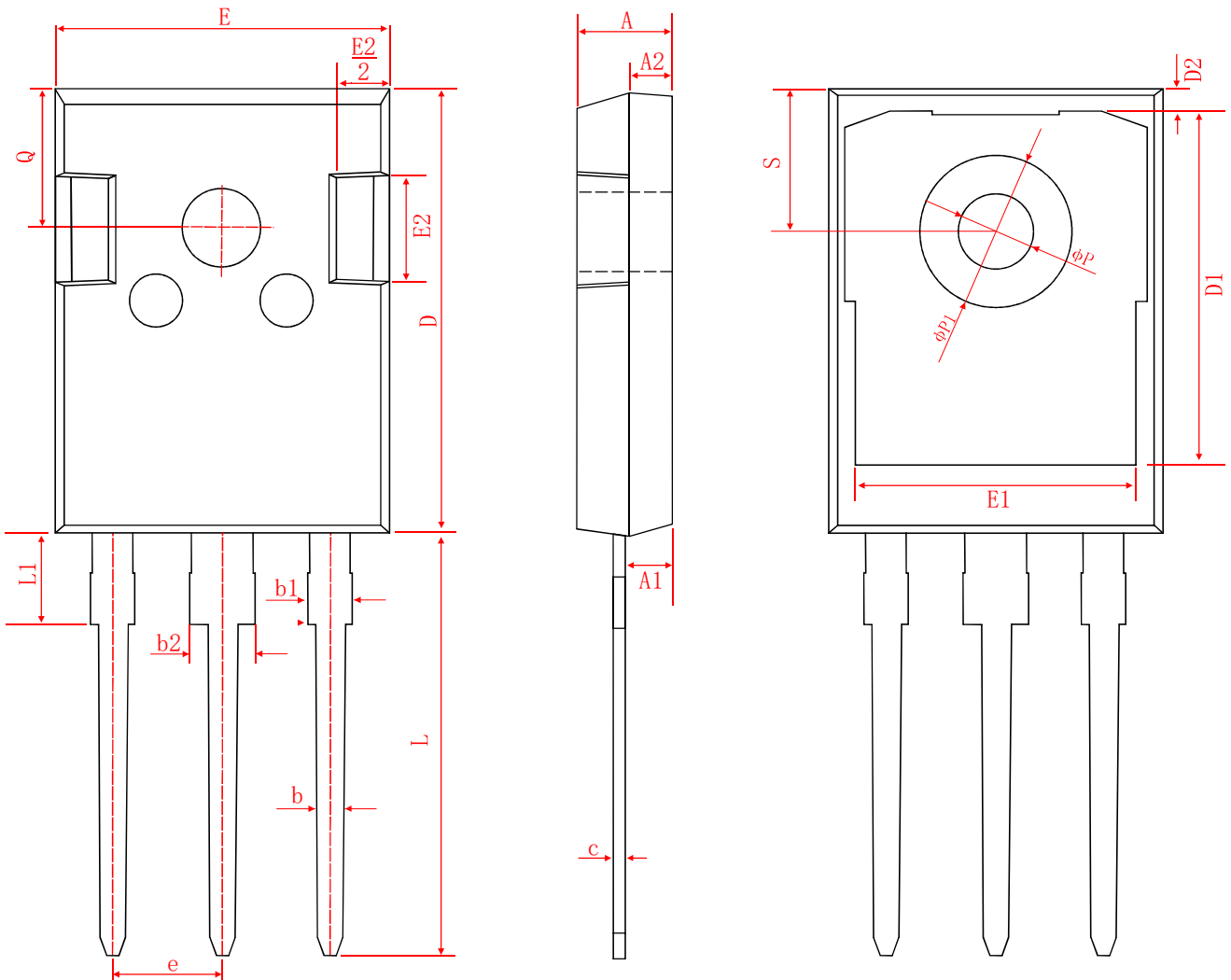


**Transient Thermal Impedance, Junction-Case**





# TO-247-A Package Outline Dimensions



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	4.90	5.10	0.193	0.201
A1	2.31	2.51	0.091	0.099
A2	1.90	2.10	0.075	0.083
b	1.15	1.25	0.045	0.049
b1	1.95	2.25	0.077	0.089
b2	2.95	3.25	0.116	0.128
c	0.55	0.65	0.022	0.026
D	20.90	21.10	0.823	0.831
D1	16.35	16.75	0.644	0.659
D2	1.05	1.35	0.041	0.053
e	5.44 TYP.		0.214 TYP.	
E	15.70	15.90	0.618	0.626
E1	13.10	13.40	0.516	0.528
E2	4.90	5.10	0.193	0.201
Q	5.60	6.00	0.220	0.236
S	6.05	6.25	0.238	0.246
L	19.80	20.15	0.780	0.793
L1		4.30		0.169
ΦP	3.45	3.65	0.136	0.144
ΦP1	7.03	7.33	0.277	0.289